Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/698,452	NAKAHARA ET AL.	
Examiner	Art Unit	
Scott B. Geyer	2829	

SEARCHED				
Class	Subclass	Date	Examiner	
438	106, 108	2/3/2005	SBG	
438	112, 124	2/3/2005	SBG	
438	125, 126	2/3/2005	SBG	
438	127	2/3/2005	SBG	

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
438	108, 127	2/3/2005	SBG		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
09/902,154 - refs checked	2/3/200	5 SBG		
search notes attached	2/3/200	5 SBG		
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